

Application No.: 10/568,378

Docket No.: REGIM 3.3-080

IN THE ABSTRACT

Please amend the Abstract in accordance with the attached revised Abstract. The revised Abstract is provided both as marked to show revisions and in finalized form.



ABSTRACT

A device determines at least one characteristic of electromagnetic radiation emitted from a test object. A support receives the object. A network of probes is distributed along a substantially circular arc, and the support is disposed in a plane formed by the network of probes or in a plane parallel to the plane formed by the network of probes. The network of probes or the support is pivoted in the plane formed by the network of probes or in the plane parallel to the plane formed by the network of probes about a point located in that plane to vary an angle formed between a given one of the network of probes and the support, and thereby allow measurements to be taken at plural angular positions of the network of probes relative to the test object.